

STW30NM60D

N-channel 600V - 0.125Ω - 30A - TO-247 Fast diode MDmesh[™] Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D
STW30NM60D	600V	< 0.145Ω	30A

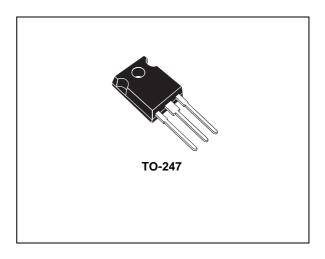
- High dv/dt and avalanche capabilities
- 100% avalanche rated
- Low input capacitance and gate charge
- Low gate input resistance
- Fast internal recovery diode

Description

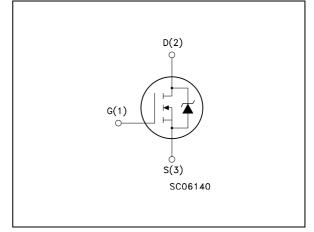
The FDmesh[™] associates all advantages of reduced on-resistance and fast switching with an intrinsic fast-recovery body diode. It is therefore strongly recommended for bridge topologies, in particular ZVS phase-shift converters.

Applications

Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STW30NM60D	W30NM60D	TO-247	Tube

Contents

1	Electrical ratings	3
2	Electrical characteristics	4
	2.1 Electrical characteristics (curves)	6
3	Test circuit	8
4	Package mechanical data	9
5	Revision history1	1



1

Electrical ratings

Table 1.	Absolute	maximum	ratings
	Aboolate	maximum	ruungo

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	600	V
V _{DGR}	Drain-gate voltage ($R_{GS} = 20k\Omega$)	600	V
V _{GS}	Gate- source voltage	± 30	V
I _D	Drain current (continuous) at $T_C = 25^{\circ}C$	30	A
I _D	Drain current (continuous) at T _C = 100°C	18.9	A
I _{DM} ⁽¹⁾	Drain current (pulsed)	120	A
P _{TOT}	Total dissipation at $T_{C} = 25^{\circ}C$	312	W
	Derating factor	2.5	W/°C
dv/dt ⁽²⁾	Peak diode recovery voltage slope	20	V/ns
T _j T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

1. Pulse width limited by safe operating area

2. $I_{SD} \leq$ 30A, di/dt \leq 400A/µs, $V_{DD} =$ 80% $V_{(BR)DSS}$

Table 2. Thermal resistance

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case max	0.4	°C/W
Rthj-amb	Thermal resistance junction-ambient max	62.5	°C/W
Τ _Ι	Maximum lead temperature for soldering purpose	300	°C

Table 3. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T _j max)	15	A
E _{AS}	Single pulse avalanche energy (starting $T_j = 25^{\circ}C$, $I_D = I_{AR}$, $V_{DD} = 50V$)	740	mJ



2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

	Table	4.	Static
--	-------	----	--------

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 1mA$, $V_{GS} = 0$	600			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = Max rating V _{DS} = Max rating, @125°C			10 100	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 20V$			± 10	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3	4	5	V
R _{DS(on}	Static drain-source on resistance	V _{GS} = 10V, I _D = 15A		0.125	0.145	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15V , I _D = 15A		16		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 25V, f = 1MHz, V _{GS} = 0		2520 800 75		pF pF pF
C _{oss eq.} ⁽²⁾	Equivalent output capacitance	$V_{GS} = 0V, V_{DS} = 0 \text{ to } 480V$		390		pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 480V, I_D = 30A, V_{GS} = 10V <i>Figure 15</i>		82 24 42	115	nC nC nC

1. Pulsed: Pulse duration = $300\mu s$, duty cycle 1.5 %

2. $C_{oss\ eq}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off-delay time Fall time	$V_{DD} = 300V, I_D = 15A,$ $R_G = 4.7\Omega, V_{GS} = 10V$ Figure 14		32 33 75 35		ns ns ns ns

Table 6. Switching on/off (inductive load)

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)				30 120	A A
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 30A, V_{GS} = 0$			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 30A, di/dt=100A/μs V _{DD} = 50V,Tj=25°C <i>Figure 17</i>		165 1.1 14		ns nC A

1. Pulse width limited by safe operating area.

2. Pulsed: Pulse duration = 300μ s, duty cycle 1.5 %



2.1 Electrical characteristics (curves)

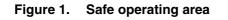
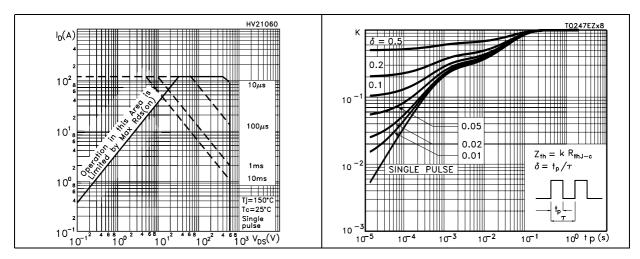
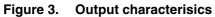
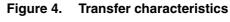
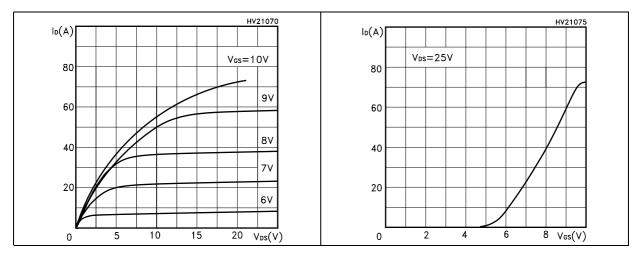


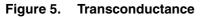
Figure 2. Thermal impedance



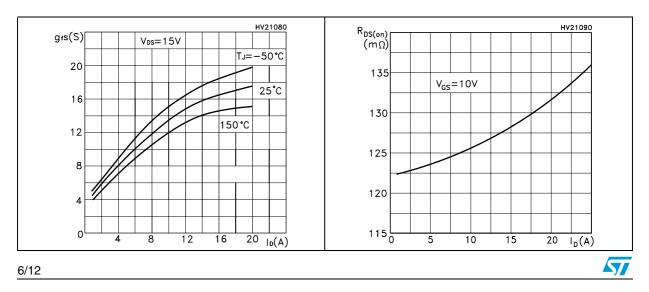












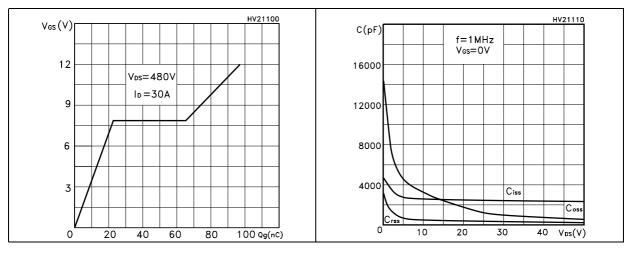


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

Figure 9. Normalized gate threshold voltage vs temperature

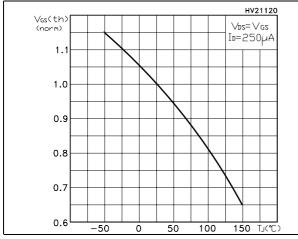


Figure 11. Source-drain diode forward characteristics

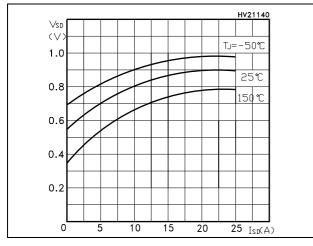
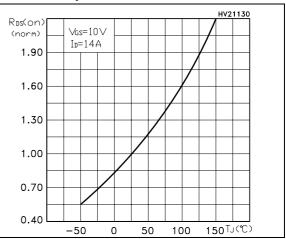


Figure 10. Normalized on resistance vs temperature





57

3 Test circuit

Figure 12. Unclamped inductive load test circuit

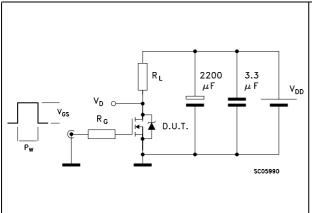


Figure 14. Switching times test circuit for resistive load

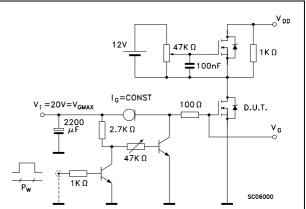
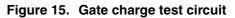
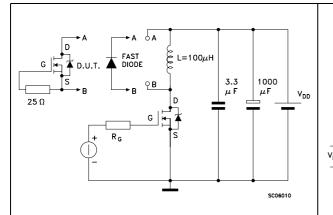


Figure 13. Unclamped inductive wafeform





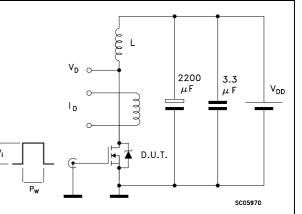
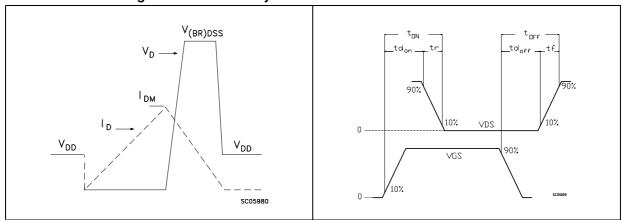


Figure 16. Test circuit for inductive load Figure 17. Switching time waveform switching and diode recovery times



4 Package mechanical data

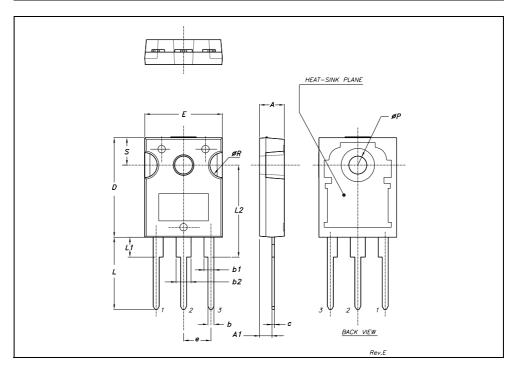
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



57

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А	4.85		5.15	0.19		0.20
A1	2.20		2.60	0.086		0.102
b	1.0		1.40	0.039		0.055
b1	2.0		2.40	0.079		0.094
b2	3.0		3.40	0.118		0.134
С	0.40		0.80	0.015		0.03
D	19.85		20.15	0.781		0.793
Е	15.45		15.75	0.608		0.620
е		5.45			0.214	
L	14.20		14.80	0.560		0.582
L1	3.70		4.30	0.14		0.17
L2		18.50			0.728	
øP	3.55		3.65	0.140		0.143
øR	4.50		5.50	0.177		0.216
S		5.50			0.216	1





5 Revision history

Table 8.	Revision	history

Date	Revision	Changes	
24-June-2004	1	The document change from "ADVANCED" to "COMPLETE". New stylesheet. Rds(on) Max@10V changed. See <i>Table 4</i> .	
06-Dec-2005	2	Inserted ecopack indication	
20-Dec-2005	3	Modified value on Source drain diode	
24-Jan-2006	4	Changed unit on <i>Dynamic</i>	
13-Jul-2006	5	New template, modified unit on Source drain diode	



Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2006 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan -Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

